- **State-of-the-Art *EPIC-*II*B*™ BiCMOS Design Significantly Reduces Power Dissipation**

- **ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)**

- **Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17**

- **Typical V_{OLP} (Output Ground Bounce) < 1 V at V_{CC} = 5 V, T_A = 25°C**

- **High-Impedance State During Power Up and Power Down**

- **High-Drive Outputs (–32-mA I_{OH}, 64-mA I_{OL})**

- **Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK), Ceramic Flat (W) Package, and Plastic (NT) and Ceramic (JT) DIPs**

SN54ABT841 . . . JT OR W PACKAGE
SN74ABT841A . . . DB, DW, NT, OR PW PACKAGE
(TOP VIEW)

$\overline{OE}$	1	24 V_{CC}
1D	2	23 1Q
2D	3	22 2Q
3D	4	21 3Q
4D	5	20 4Q
5D	6	19 5Q
6D	7	18 6Q
7D	8	17 7Q
8D	9	16 8Q
9D	10	15 9Q
10D	11	14 10Q
GND	12	13 LE

SN54ABT841 . . . FK PACKAGE
(TOP VIEW)

Pins (top, left to right): 2D, 1D, $\overline{OE}$, NC, V_{CC}, 1Q, 2Q
Pin numbers top: 4 3 2 1 28 27 26

Left	Pin	Right	Pin
3D	5	3Q	25
4D	6	4Q	24
5D	7	5Q	23
NC	8	NC	22
6D	9	6Q	21
7D	10	7Q	20
8D	11	8Q	19

Pin numbers bottom: 12 13 14 15 16 17 18
Pins (bottom): 9D, 10D, GND, NC, LE, 10Q, 9Q

NC – No internal connection

description

The SN54ABT841 and SN74ABT841A 10-bit latches are designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

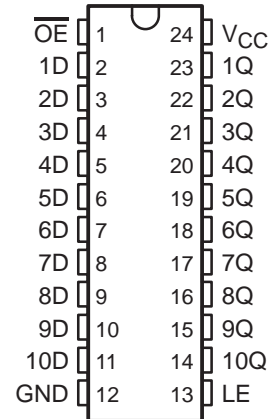The ten transparent D-type latches provide true data at their outputs.

A buffered output-enable ($\overline{OE}$) input can be used to place the ten outputs in either a normal logic state (high or low logic levels) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pullup components.

$\overline{OE}$ does not affect the internal operations of the latch. Previously stored data can be retained or new data can be entered while the outputs are in the high-impedance state.
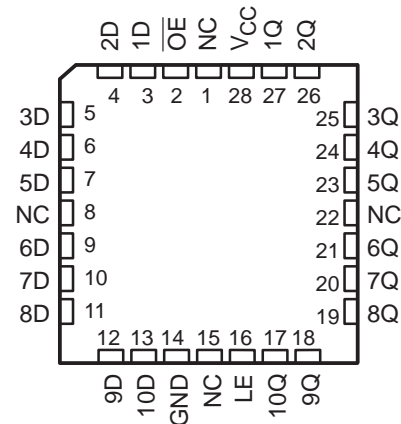
When V_{CC} is between 0 and 2.1 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 2.1 V, $\overline{OE}$ should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54ABT841 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74ABT841A is characterized for operation from –40°C to 85°C.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

EPIC-IIB is a trademark of Texas Instruments Incorporated.

TEXAS
INSTRUMENTS

FUNCTION TABLE

INPUTS			OUTPUT
$\overline{OE}$	LE	D	Q
L	H	H	H
L	H	L	L
L	L	X	Q_0
H	X	X	Z

logic symbol[†]

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for the DB, DW, JT, NT, PW, and W packages.

logic diagram (positive logic)
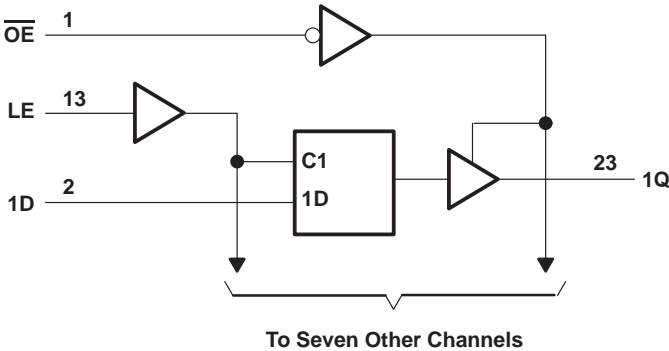
To Seven Other Channels

Pin numbers shown are for the DB, DW, JT, NT, PW, and W packages.

TEXAS INSTRUMENTS

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC} . . . . −0.5 V to 7 V
Input voltage range, V_I (see Note 1) . . . . −0.5 V to 7 V
Voltage range applied to any output in the high or power-off state, V_O . . . . −0.5 V to 5.5 V
Current into any output in the low state, I_O: SN54ABT841 . . . . 96 mA
SN74ABT841A . . . . 128 mA
Input clamp current, I_{IK} (V_I < 0) . . . . −18 mA
Output clamp current, I_{OK} (V_O < 0) . . . . −50 mA
Package thermal impedance, θ_{JA} (see Note 2): DB package . . . . 104°C/W
DW package . . . . 81°C/W
NT package . . . . 67°C/W
PW package . . . . 120°C/W
Storage temperature range, T_{stg} . . . . −65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51, except for through-hole packages, which use a trace length of zero.

recommended operating conditions (see Note 3)

		SN54ABT841		SN74ABT841A		UNIT
		MIN	MAX	MIN	MAX	
V_{CC}	Supply voltage	4.5	5.5	4.5	5.5	V
V_{IH}	High-level input voltage	2		2		V
V_{IL}	Low-level input voltage		0.8		0.8	V
V_I	Input voltage	0	V_{CC}	0	V_{CC}	V
I_{OH}	High-level output current		−24		−32	mA
I_{OL}	Low-level output current		48		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate		5		5	ns/V
$\Delta t/\Delta V_{CC}$	Power-up ramp rate	200		200		µs/V
T_A	Operating free-air temperature	−55	125	−40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

![Texas Instruments logo] **TEXAS INSTRUMENTS**

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		$T_A = 25°C$			SN54ABT841		SN74ABT841A		UNIT
			MIN	TYP†	MAX	MIN	MAX	MIN	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = −18 mA			−1.2		−1.2		−1.2	V
V_{OH}	V_{CC} = 4.5 V,	I_{OH} = −3 mA	2.5			2.5		2.5		V
	V_{CC} = 5 V,	I_{OH} = −3 mA	3			3		3		
	V_{CC} = 4.5 V	I_{OH} = −24 mA	2			2				
		I_{OH} = −32 mA	2*					2		
V_{OL}	V_{CC} = 4.5 V	I_{OL} = 48 mA			0.55		0.55			V
		I_{OL} = 64 mA			0.55*				0.55	
V_{hys}				100						mV
I_I	V_{CC} = 0 to 5.5 V,	V_I = V_{CC} or GND			±1		±1		±1	µA
$I_{OZPU}‡$	V_{CC} = 0 to 2.1 V, V_O = 0.5 V to 2.7 V, $\overline{OE}$ = X				±50		±50		±50	µA
$I_{OZPD}‡$	V_{CC} = 2.1 V to 0, V_O = 0.5 V to 2.7 V, $\overline{OE}$ = X				±50		±50		±50	µA
I_{OZH}	V_{CC} = 2.1 V to 5.5 V, V_O = 2.7 V, $\overline{OE} \geq 2$ V				10		10		10	µA
I_{OZL}	V_{CC} = 2.1 V to 5.5 V, V_O = 0.5 V, $\overline{OE} \geq 2$ V				−10		−10		−10	µA
I_{off}	V_{CC} = 0,	V_I or $V_O \leq 4.5$ V			±100				±100	µA
I_{CEX}	V_{CC} = 5.5 V, V_O = 5.5 V	Outputs high			50		50		50	µA
$I_O§$	V_{CC} = 5.5 V,	V_O = 2.5 V	−50	−140	−180	−50	−180	−50	−180	mA
I_{CC}	V_{CC} = 5.5 V, I_O = 0, V_I = V_{CC} or GND	Outputs high		1**	250**		280		250	µA
		Outputs low		24**	38¶**		45¶		38¶	mA
		Outputs disabled		0.5**	250**		280		250	µA
$\Delta I_{CC}#$	V_{CC} = 5.5 V, One input at 3.4 V, Other inputs at V_{CC} or GND	Outputs enabled			1.5		1.5		1.5	mA
		Outputs disabled			250**		280		250	µA
		Control inputs			1.5		1.5		1.5	mA
C_i	V_I = 2.5 V or 0.5 V			4						pF
C_o	V_O = 2.5 V or 0.5 V			7						pF

* On products compliant to MIL-PRF-38535, this parameter does not apply.
** These limits apply only to the SN74ABT841A.
† All typical values are at V_{CC} = 5 V.
‡ This parameter is characterized, but not production tested.
§ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.
¶ This limit may vary among suppliers.
# This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			V_{CC} = 5 V, $T_A = 25°C$		SN54ABT841		SN74ABT841A		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
t_w	Pulse duration, LE high or low		3.3		3.3		3.3		ns
t_{su}	Setup time, data before LE↓	High	2.5		2.5		2.5		ns
		Low	1.5		1.5		1.5		
t_h	Hold time, data after LE↓	High	1.5		1.5		1.5		ns
		Low	1.5		2		1.5		

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN54ABT841 V_{CC} = 5 V, T_A = 25°C					UNIT
			MIN	TYP	MAX	MIN	MAX	
t_{PLH}	D	Q	1†	4.1	5.5	1†	6.8	ns
t_{PHL}			1.5†	4	5.5	1.5†	6.8	
t_{PLH}	LE	Q	1.6†	4.1	6.6†	1.6†	7.4	ns
t_{PHL}			2†	4.6	6.2	2†	6.8	
t_{PZH}	$\overline{OE}$	Q	1	3	4.9†	1	5.8	ns
t_{PZL}			2.2	4.1	5.7†	2.2	6.5	
t_{PHZ}	$\overline{OE}$	Q	2†	4.7	6.2	2†	7.2	ns
t_{PLZ}			1.5†	4.6	6.1	1.5†	6.6	

† This data sheet limit may vary among suppliers.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN74ABT841A V_{CC} = 5 V, T_A = 25°C					UNIT
			MIN	TYP	MAX	MIN	MAX	
t_{PLH}	D	Q	1.4†	4.1	5.5	1.4†	6.2†	ns
t_{PHL}			1.5†	4	5.5	1.5†	6.2	
t_{PLH}	LE	Q	2.1†	4.1	5.9†	2.1†	6.5†	ns
t_{PHL}			2.4†	4.6	6.2	2.4†	6.7	
t_{PZH}	$\overline{OE}$	Q	1	3	4.7†	1	5.3†	ns
t_{PZL}			2.2	4.1	5.7†	2.2	6.3†	
t_{PHZ}	$\overline{OE}$	Q	2.6†	4.7	6.2	2.6†	7.1	ns
t_{PLZ}			1.9†	4.6	6.1	1.9†	6.5	

† This data sheet limit may vary among suppliers.

TEXAS
INSTRUMENTS

PARAMETER MEASUREMENT INFORMATION
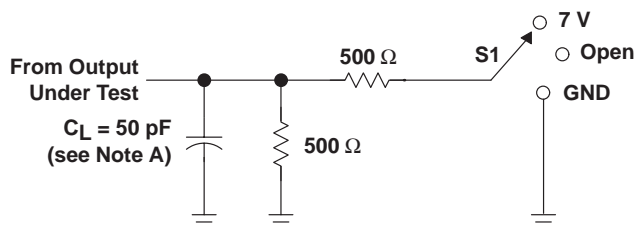
TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	7 V
t_{PHZ}/t_{PZH}	Open

LOAD CIRCUIT
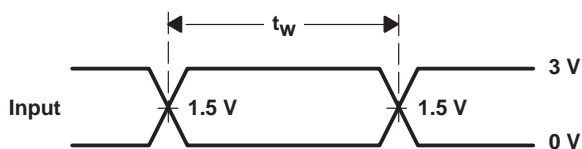
VOLTAGE WAVEFORMS
PULSE DURATION

VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES

VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES
INVERTING AND NONINVERTING OUTPUTS

VOLTAGE WAVEFORMS
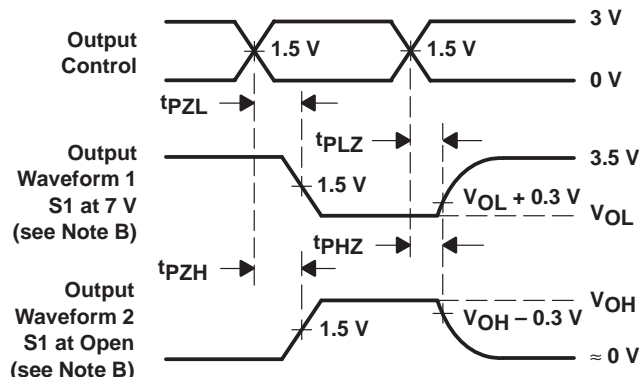**ENABLE AND DISABLE TIMES**
LOW- AND HIGH-LEVEL ENABLING

NOTES: A. C_L includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.
Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_O = 50 Ω, t_r ≤ 2.5 ns, t_f ≤ 2.5 ns.
D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9676901Q3A	ACTIVE	LCCC	FK	28	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9676901Q3A SNJ54ABT 841FK	Samples
5962-9676901QKA	ACTIVE	CFP	W	24	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9676901QK A SNJ54ABT841W	Samples
5962-9676901QLA	ACTIVE	CDIP	JT	24	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9676901QL A SNJ54ABT841JT	Samples
SN74ABT841ADBLE	OBSOLETE	SSOP	DB	24		TBD	Call TI	Call TI	-40 to 85		
SN74ABT841ADBR	ACTIVE	SSOP	DB	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB841A	Samples
SN74ABT841ADBRE4	ACTIVE	SSOP	DB	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB841A	Samples
SN74ABT841ADW	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT841A	Samples
SN74ABT841ADWG4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT841A	Samples
SN74ABT841ADWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT841A	Samples
SN74ABT841ADWRE4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT841A	Samples
SN74ABT841ANT	ACTIVE	PDIP	NT	24	15	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-40 to 85	SN74ABT841ANT	Samples
SN74ABT841APW	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB841A	Samples
SN74ABT841APWLE	OBSOLETE	TSSOP	PW	24		TBD	Call TI	Call TI	-40 to 85		
SN74ABT841APWR	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB841A	Samples
SNJ54ABT841FK	ACTIVE	LCCC	FK	28	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9676901Q3A SNJ54ABT 841FK	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SNJ54ABT841JT	ACTIVE	CDIP	JT	24	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9676901QLA SNJ54ABT841JT	Samples
SNJ54ABT841W	ACTIVE	CFP	W	24	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9676901QKA SNJ54ABT841W	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN54ABT841 :

- Catalog: SN74ABT841

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

PACKAGE MATERIALS INFORMATION

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TAPE DIMENSIONS

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ABT841ADBR	SSOP	DB	24	2000	330.0	16.4	8.2	8.8	2.5	12.0	16.0	Q1
SN74ABT841ADWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
SN74ABT841APWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ABT841ADBR	SSOP	DB	24	2000	367.0	367.0	38.0
SN74ABT841ADWR	SOIC	DW	24	2000	367.0	367.0	45.0
SN74ABT841APWR	TSSOP	PW	24	2000	367.0	367.0	38.0

JT (R-GDIP-T**)

CERAMIC DUAL-IN-LINE

24 LEADS SHOWN
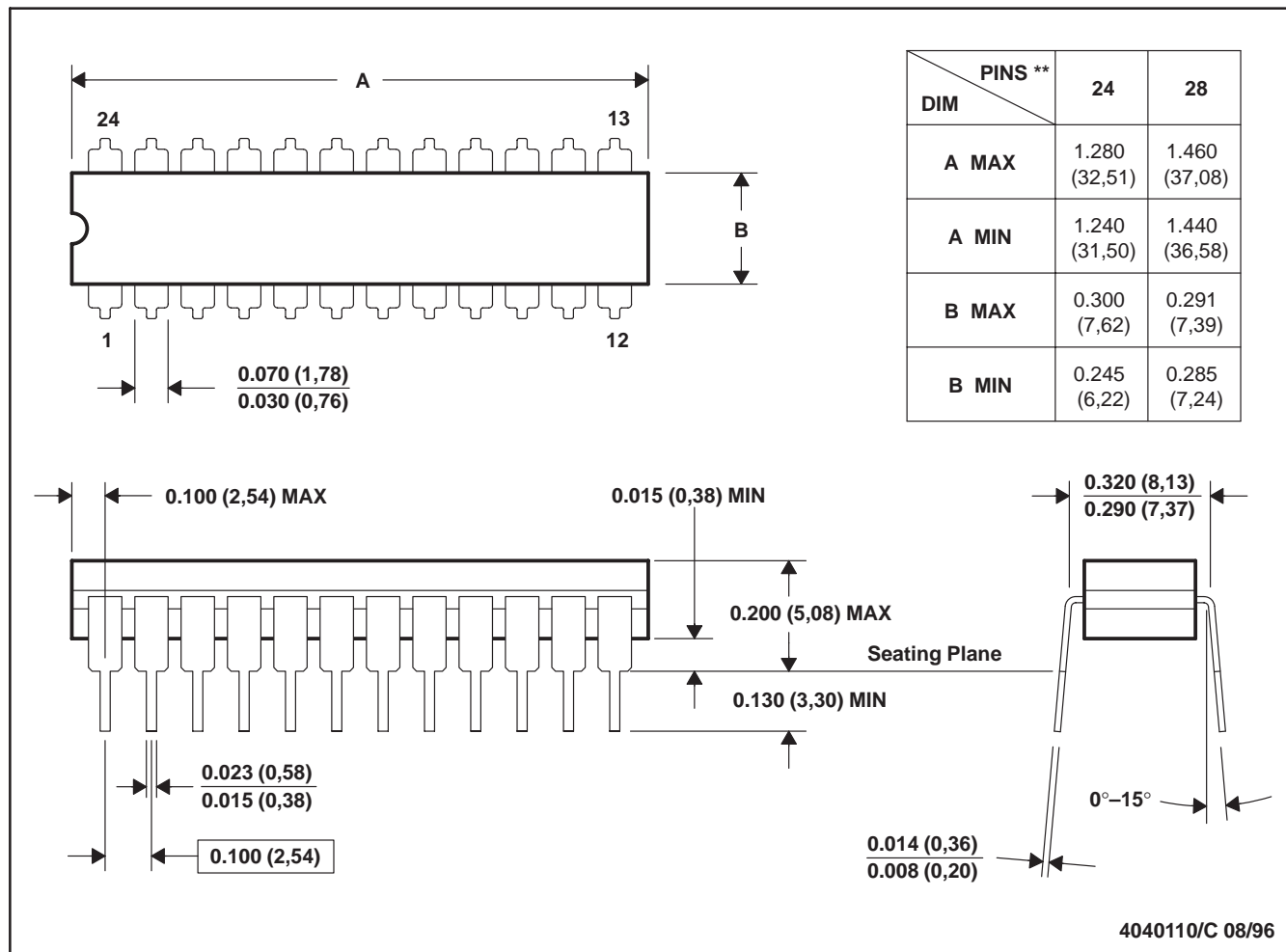
	PINS **	24	28
DIM			
A MAX		1.280 (32,51)	1.460 (37,08)
A MIN		1.240 (31,50)	1.440 (36,58)
B MAX		0.300 (7,62)	0.291 (7,39)
B MIN		0.245 (6,22)	0.285 (7,24)

A

24   13

B

1   12

0.070 (1,78)
0.030 (0,76)

0.100 (2,54) MAX

0.015 (0,38) MIN

0.320 (8,13)
0.290 (7,37)

0.200 (5,08) MAX

Seating Plane

0.130 (3,30) MIN

0.023 (0,58)
0.015 (0,38)

0.100 (2,54)

0°–15°

0.014 (0,36)
0.008 (0,20)

4040110/C 08/96

NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification.
E. Falls within MIL STD 1835 GDIP3-T24, GDIP4-T28, and JEDEC MO-058 AA, MO-058 AB

W (R−GDFP−F24)   CERAMIC DUAL FLATPACK

Base And Seating Plane

$\dfrac{0.375\ (9,53)}{0.340\ (8,64)}$

$\dfrac{0.045\ (1,14)}{0.026\ (0,66)}$

$\dfrac{0.090\ (2,29)}{0.045\ (1,14)}$

$\dfrac{0.006\ (0,15)}{0.004\ (0,10)}$

$\dfrac{0.360\ (9,14)}{0.240\ (6,10)}$ $\dfrac{0.395\ (10,03)}{0.360\ (9,14)}$ $\dfrac{0.360\ (9,14)}{0.240\ (6,10)}$

$\dfrac{0.019\ (0,48)}{0.015\ (0,38)}$

1   24

$\dfrac{0.640\ (16,26)}{0.490\ (12,45)}$

0.050 (1,27)
TYP

$\dfrac{0.030\ (0,76)}{0.015\ (0,38)}$

12   30° TYP   13

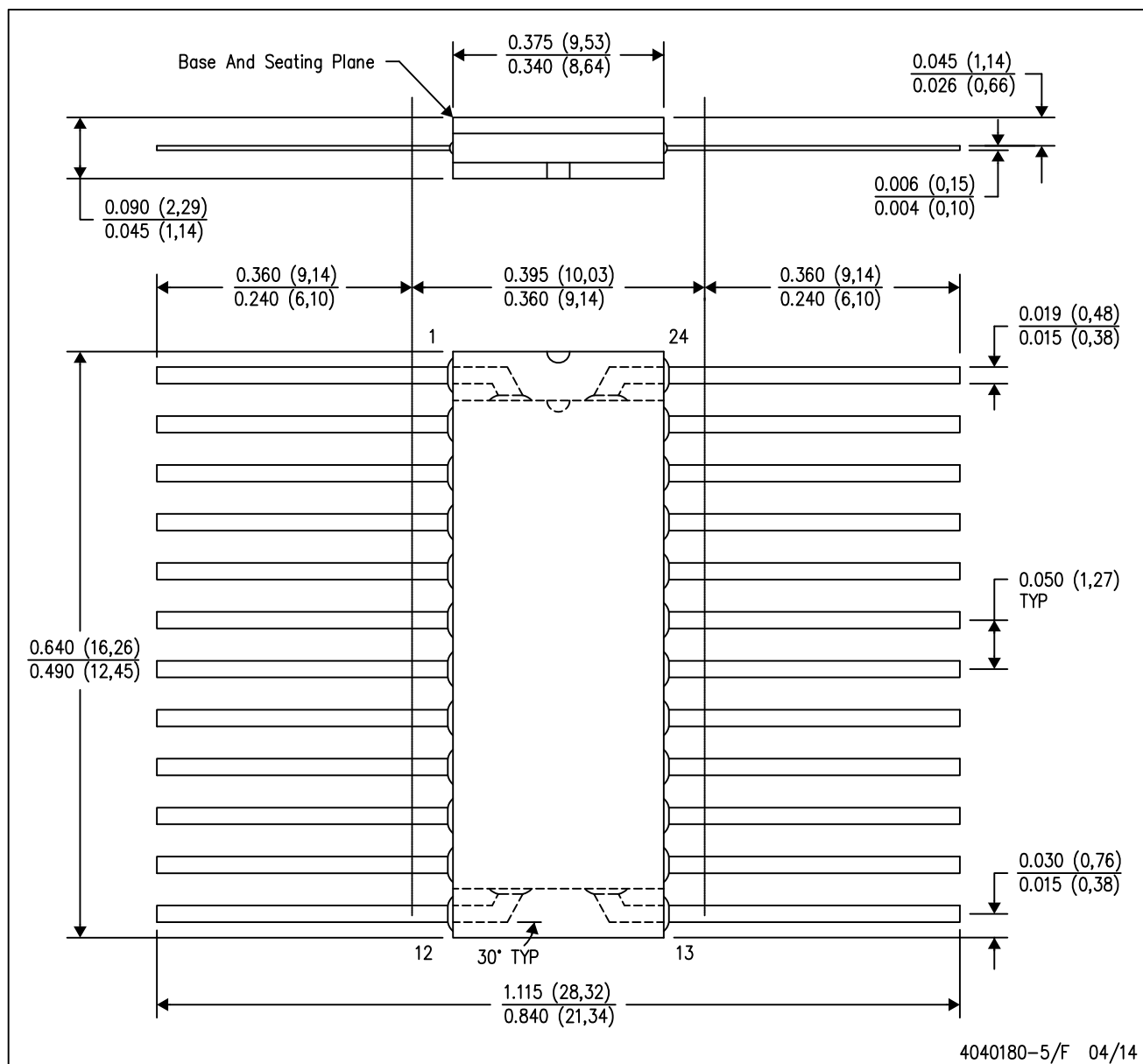$\dfrac{1.115\ (28,32)}{0.840\ (21,34)}$

4040180−5/F   04/14

NOTES: A.   All linear dimensions are in inches (millimeters).
         B.   This drawing is subject to change without notice.
         C.   This package can be hermetically sealed with a ceramic lid using glass frit.
         D.   Index point is provided on cap for terminal identification only.
         E.   Falls within Mil−Std 1835 GDFP2−F20

FK (S−CQCC−N**)   LEADLESS CERAMIC CHIP CARRIER
28 TERMINAL SHOWN

NO. OF TERMINALS **	A		B	
	MIN	MAX	MIN	MAX
20	0.342 (8,69)	0.358 (9,09)	0.307 (7,80)	0.358 (9,09)
28	0.442 (11,23)	0.458 (11,63)	0.406 (10,31)	0.458 (11,63)
44	0.640 (16,26)	0.660 (16,76)	0.495 (12,58)	0.560 (14,22)
52	0.740 (18,78)	0.761 (19,32)	0.495 (12,58)	0.560 (14,22)
68	0.938 (23,83)	0.962 (24,43)	0.850 (21,6)	0.858 (21,8)
84	1.141 (28,99)	1.165 (29,59)	1.047 (26,6)	1.063 (27,0)

B SQ
A SQ

0.020 (0,51) / 0.010 (0,25)

0.020 (0,51) / 0.010 (0,25)

0.080 (2,03) / 0.064 (1,63)

0.055 (1,40) / 0.045 (1,14)

0.045 (1,14) / 0.035 (0,89)

0.028 (0,71) / 0.022 (0,54)

0.050 (1,27)

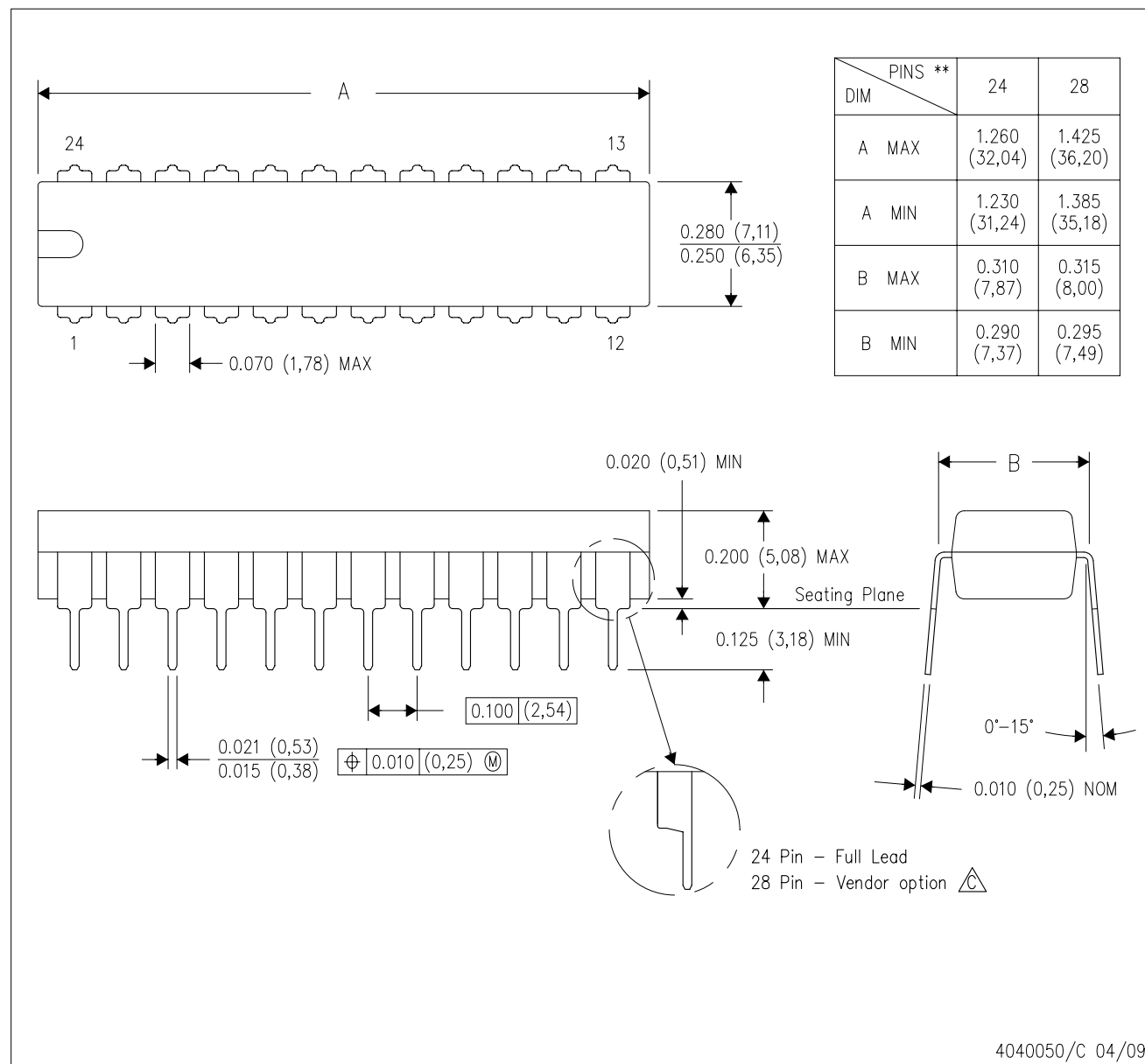0.045 (1,14) / 0.035 (0,89)

4040140/D 01/11

NOTES:
  A. All linear dimensions are in inches (millimeters).
  B. This drawing is subject to change without notice.
  C. This package can be hermetically sealed with a metal lid.
  D. Falls within JEDEC MS−004

NT (R−PDIP−T**) PLASTIC DUAL−IN−LINE PACKAGE
24 PINS SHOWN

PINS ** DIM	24	28
A MAX	1.260 (32,04)	1.425 (36,20)
A MIN	1.230 (31,24)	1.385 (35,18)
B MAX	0.310 (7,87)	0.315 (8,00)
B MIN	0.290 (7,37)	0.295 (7,49)

A

24   13

0.280 (7,11)
0.250 (6,35)

1   12

0.070 (1,78) MAX

0.020 (0,51) MIN

0.200 (5,08) MAX

Seating Plane

0.125 (3,18) MIN

B

0.100 (2,54)

0.021 (0,53)
0.015 (0,38)   ⊕ 0.010 (0,25) Ⓜ

0°−15°

0.010 (0,25) NOM

24 Pin − Full Lead
28 Pin − Vendor option ⚠C

4040050/C 04/09

NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M−1994.
B. This drawing is subject to change without notice.
⚠C The 28 pin end lead shoulder width is a vendor option, either half or full width.

TEXAS INSTRUMENTS
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DW (R-PDSO-G24)   PLASTIC SMALL OUTLINE

$\frac{0.614\ (15,60)}{0.598\ (15,20)}$

24   13

$\frac{0.419\ (10,63)}{0.393\ (9,97)}$

$\frac{0.299\ (7,60)}{0.291\ (7,40)}$

1   12

Pin 1
Index Area

0.050 (1,27)

$\frac{0.020\ (0,51)}{0.012\ (0,31)}$

⊕ | 0.010 (0,25) Ⓜ

0.104 (2,65) Max

$\frac{0.012\ (0,30)}{0.004\ (0,10)}$

$\frac{0.013\ (0,33)}{0.008\ (0,20)}$

◁ | 0.004 (0,10)

Gauge Plane

Seating Plane

0.010 (0,25)   0°-8°

$\frac{0.050\ (1,27)}{0.016\ (0,40)}$

4040000-5/G 01/11
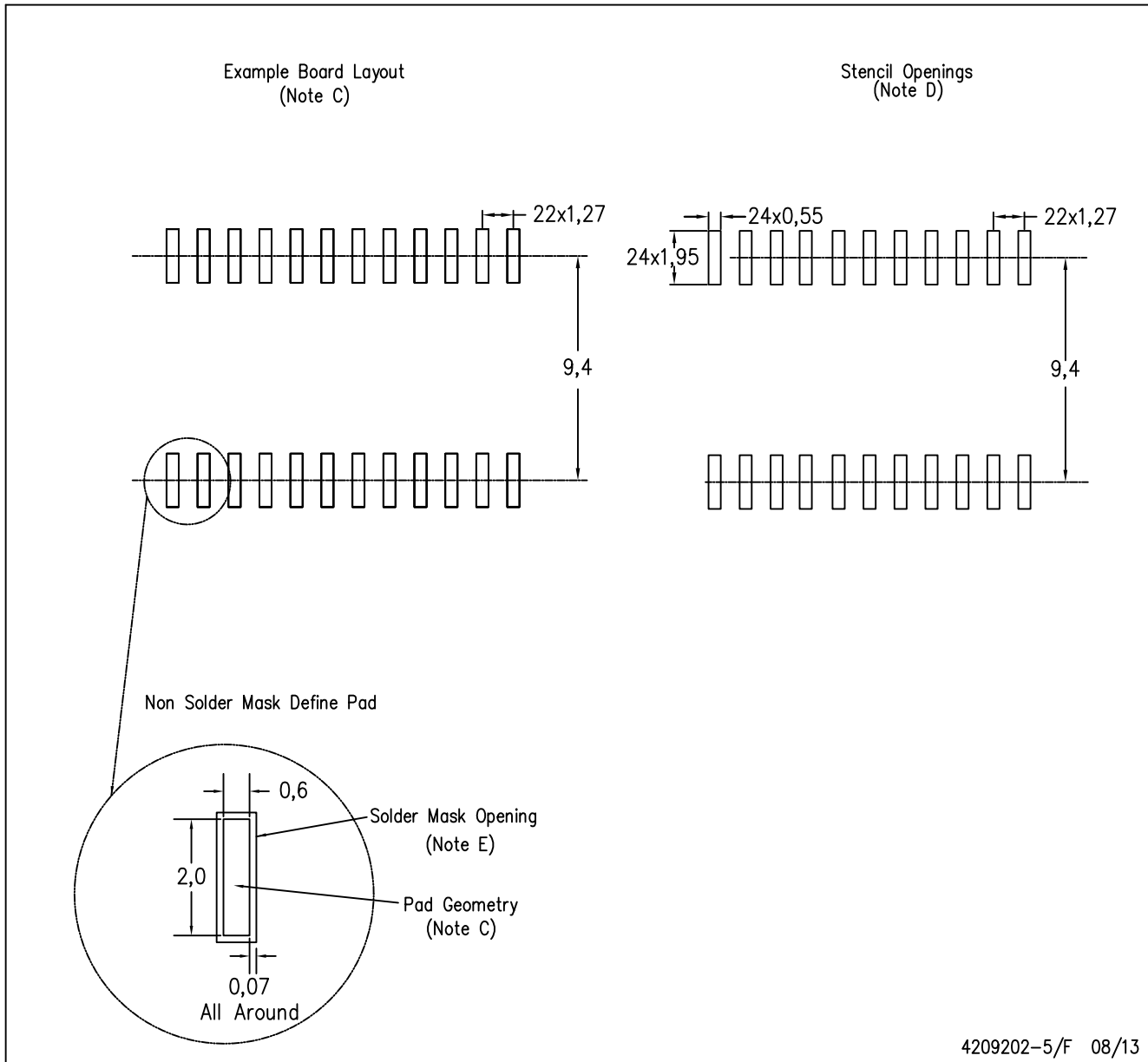
NOTES: A.   All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M–1994.
         B.   This drawing is subject to change without notice.
         C.   Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
         D.   Falls within JEDEC MS–013 variation AD.
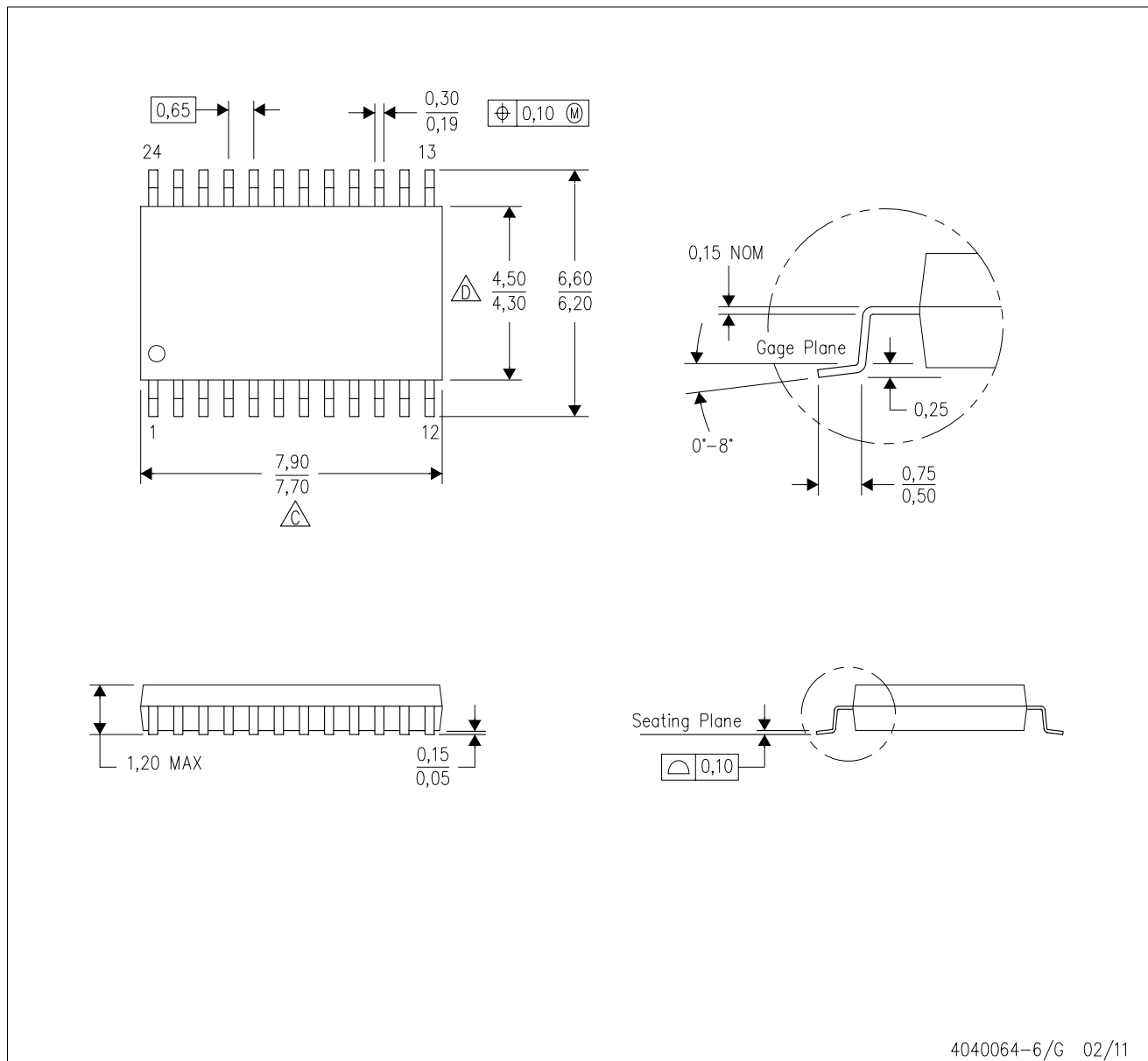
TEXAS
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DW (R−PDSO−G24)   PLASTIC SMALL OUTLINE

Example Board Layout
(Note C)

Stencil Openings
(Note D)

22x1,27

24x0,55   22x1,27

24x1,95

9,4

9,4

Non Solder Mask Define Pad

0,6

Solder Mask Opening
(Note E)

2,0

Pad Geometry
(Note C)

0,07
All Around

4209202−5/F   08/13

NOTES: A. All linear dimensions are in millimeters.
        B. This drawing is subject to change without notice.
        C. Refer to IPC7351 for alternate board design.
        D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should
            contact their board assembly site for stencil design recommendations. Refer to IPC−7525
        E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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PW (R—PDSO—G24)   PLASTIC SMALL OUTLINE

0,15 NOM

Gage Plane

0°—8°

0,25

0,75
0,50

1,20 MAX

0,15
0,05

Seating Plane

0,10
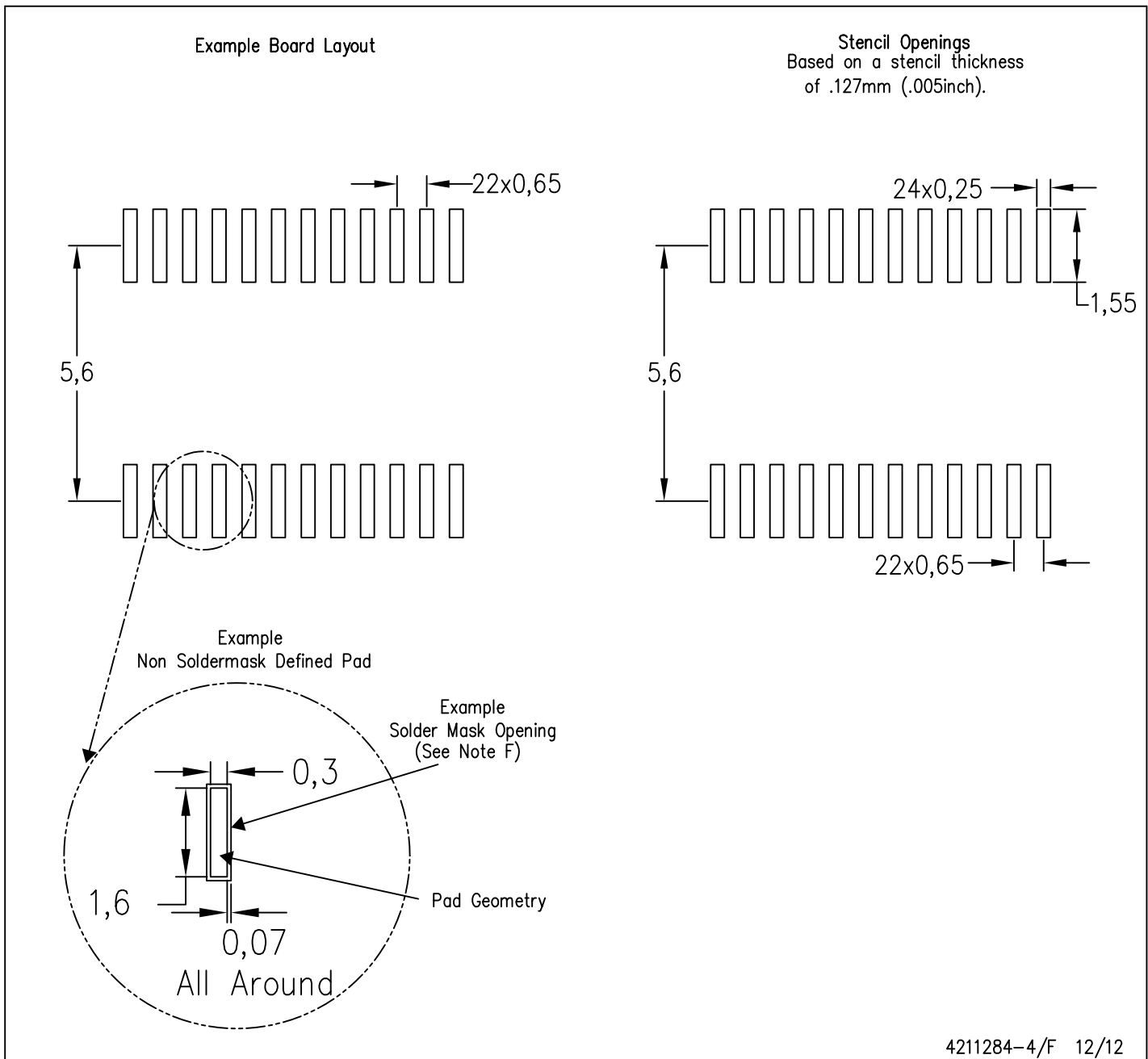
4040064—6/G 02/11

NOTES: A.   All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
         B.   This drawing is subject to change without notice.
         C.   Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall
              not exceed 0,15 each side.
         D.   Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
         E.   Falls within JEDEC MO—153

PW (R–PDSO–G24)   PLASTIC SMALL OUTLINE

Example Board Layout

Stencil Openings
Based on a stencil thickness
of .127mm (.005inch).

22x0,65

24x0,25

1,55

5,6

5,6

22x0,65

Example
Non Soldermask Defined Pad

Example
Solder Mask Opening
(See Note F)

0,3

1,6

0,07

All Around

Pad Geometry

4211284–4/F   12/12

NOTES: A.   All linear dimensions are in millimeters.
         B.   This drawing is subject to change without notice.
         C.   Publication IPC–7351 is recommended for alternate design.
         D.   Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should
              contact their board assembly site for stencil design recommendations. Refer to IPC–7525 for other stencil recommendations.
         E.   Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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INSTRUMENTS
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DB (R-PDSO-G**)   **PLASTIC SMALL-OUTLINE**

28 PINS SHOWN

	PINS **	14	16	20	24	28	30	38
DIM								
A MAX		6,50	6,50	7,50	8,50	10,50	10,50	12,90
A MIN		5,90	5,90	6,90	7,90	9,90	9,90	12,30

4040065 /E 12/01

NOTES: A. All linear dimensions are in millimeters.
    B. This drawing is subject to change without notice.
    C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
    D. Falls within JEDEC MO-150

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